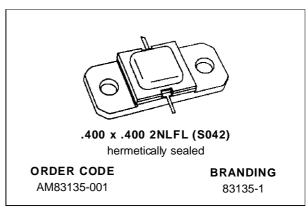


AM83135-001

RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 10:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P_{OUT} = 1.0 W MIN. WITH 5.2 dB GAIN

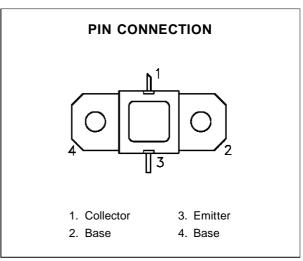


DESCRIPTION

The AM83135-001 device is a medium power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and can withstand a 10:1 output VSWR. Low RF thermal resistance, refractory/gold metallization, and automatic wire bonding techniques ensure high reliability and product consistency.

The AM83135-001 is supplied int the AMPAC™ Hermetic/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability ap-



ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit
P _{DISS}	Power Dissipation* (T _C ≤100°C)	11.5	W
Ic	Device Current*	0.45	А
Vcc	Collector-Supply Voltage*	34	V
TJ	Junction Temperature (Pulsed RF Operation)	250	°C
T _{STG}	Storage Temperature	- 65 to +200	°C

THERMAL DATA

R _{TH(j-c)}	Junction-Case Thermal Resistance*	13.0	°C/W
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^{*}Applies only to rated RF amplifier operation

February 3, 1997

ELECTRICAL SPECIFICATIONS $(T_{case} = 25^{\circ}C)$

STATIC

Comple at	Took Conditions		Value			
Symbol	Symbol Test Conditions		Min.	Тур.	Max.	Unit
ВУсво	Ic = 1mA	IE = 0mA	45	_	_	V
BV _{EBO}	I _E = 1mA	$I_C = 0mA$	3.5	_	_	V
BV _{CER}	I _C = 1mA	$R_{BE} = 10\Omega$	45	_	_	V
I _{CES}	$V_{BE} = 0V$	$V_{CE} = 30V$		_	1	mA
h _{FE}	V _{CE} = 5V	$I_C = 100 \text{mA}$	10	_	_	_

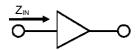
DYNAMIC

Cumb al	Took Conditions		Value			II.a.it	
Symbol		Test Conditions		Min.	Тур.	Max.	Unit
Роит	f = 3.1 — 3.5GHz	$P_{IN} = 0.3W$	$V_{CC} = 30V$	1.0	1.4	_	W
ης	f = 3.1 — 3.5GHz	$P_{IN} = 0.3W$	V _C C = 30V	27	35	_	%
G _P	f = 3.1 — 3.5GHz	$P_{IN} = 0.3W$	$V_{CC} = 30V$	5.2	6.7	_	dB

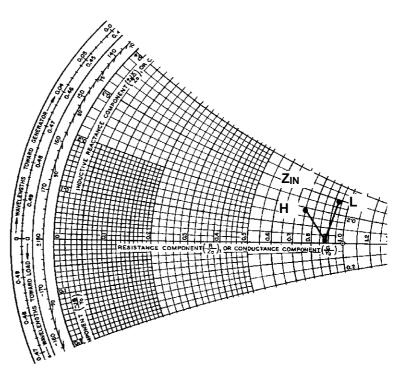
Note: Pulse Width = 100 μ S Duty Cycle = 10%

IMPEDANCE DATA



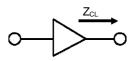


 $\begin{aligned} P_{IN} &= 0.3 \ W \\ V_{CC} &= 30 \ V \\ Z_{O} &= 50 \ ohms \end{aligned}$

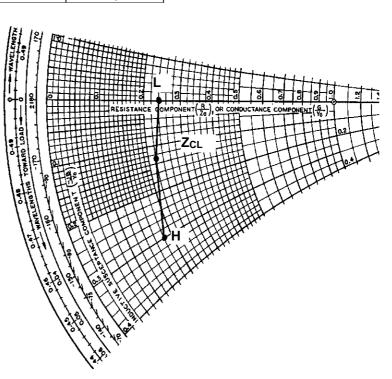


FREQ.	Z _{IN} (Ω)	Z _{CL} (Ω)
L = 3.1 GHz	46.0 + j 14.5	12.0 – j 0.0
M = 3.3 GHz	43.0 + j 10.0	11.0 – j 6.5
H = 3.5 GHz	38.0 + j 10.0	9.0 – j 15.0

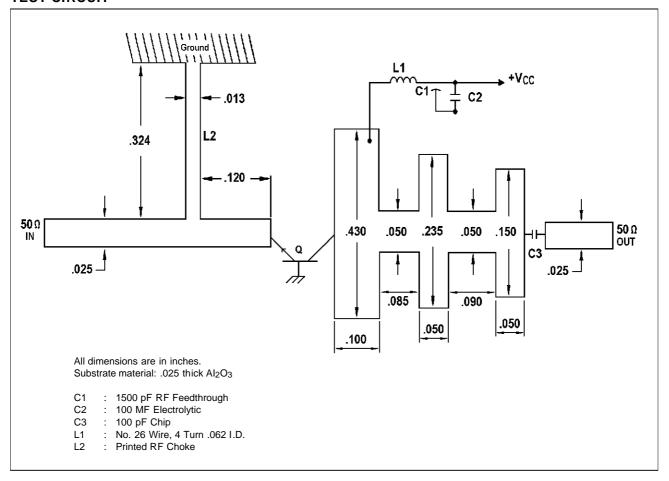
TYPICAL COLLECTOR LOAD IMPEDANCE



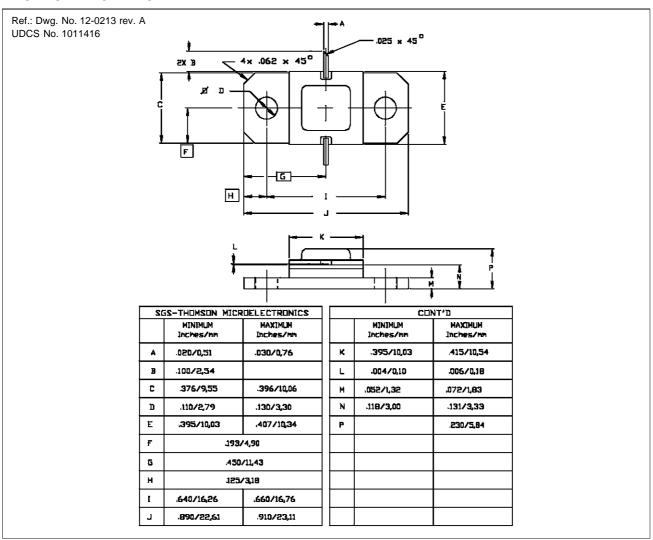
$$\begin{split} P_{IN} &= 0.3 \ W \\ V_{CC} &= 30 \ V \\ Z_{O} &= 50 \ ohms \end{split}$$



TEST CIRCUIT



PACKAGE MECHANICAL DATA



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